Plasma deposition of thin layers containing titanium and barium with the use of DBD

Malgorzata Majdak, Teresa Opalińska, Bartłomiej Wnęk, and Piotr Konarski
Tele & Radio Research Institute, 00-241 Warsaw, 44/50 Długa str., Poland

Received: 30 September 2012 / Received in final form: 6 December 2012 / Accepted: 19 December 2012
Published online: 15 February 2013 – © The Author(s) 2013

Abstract. Two different methods of deposition of thin layers containing titanium and barium with the use of dielectric barrier discharge were investigated. The first was carried out in two stages. The first stage consisted in transferring compounds containing titanium and barium from the vapor of the organic precursor to the copper substrate, while the second stage involved the etching of the organic layer in oxygen. The second method consisted in transferring titanium and barium to the copper substrate from the ceramic plate made of barium titanate, which was one of the electrodes during the plasma process. The results of analysis obtained by SIMS showed directly that both methods gave a positive result in the deposition of the thin layers containing a certain amount of titanium and barium on the surface of the copper plate. However, more effective method was that involving the properties of reaction with the metalorganic precursor. FTIR study of the layers prepared from the organic precursor indirectly showed that layers deposited on the copper plate contained compounds of barium and titanium. FTIR study also revealed that during the process of etching in oxygen, the organic layer was decreased, but it was not completely removed.

1 Introduction

A large number of works are dedicated to studies of the most widely applied ferroelectric material which nowadays is barium titanate. Materials such as BaTiO$_3$, due to their high dielectric constant [1–8], are commonly used in microelectronic devices such as multilayer ceramic capacitors [1,4–12], random-access memories (RAM) [2,4,5,7,11,12], optoelectronic devices [1,5,7,10] or sensors [6,13,14].

The miniaturization of those microelectronic devices requires reducing the size of their building materials [3,9], which should be characterized by high degree of crystallization and high smoothness [3]. For this reason, nowadays the interest in receiving the high quality of various nanolayers has been growing. Furthermore, thin layers have additional advantages in comparison with thick films – it is a higher repeatability in manufacturing process and a better control of fabrication parameters [14].

So far, applied methods of preparing BaTiO$_3$ thin layers such as sol-gel [1,7,15,16], sputtering [7], conventional furnace sintering [6] or assisted chemical vapor deposition (for example, RF-CVD) [7,9,11] required using high temperatures, usually above 500 °C [5,7,11]. However, the thermal stress often results in cracking or peeling of the deposited thin films [7,11]. Some of previously applied methods require the use of substrate, that contains one of the compounds of BaTiO$_3$. For example: in the hydrothermal-electrochemical method in which BaTiO$_3$ layer was deposited on the substrate made of titanium sheets [7] or in the electrochemical deposition used by Zeng et al. who used the TiN-coated Si substrate [11].

In this paper, two alternative methods of preparing thin layer containing barium and titanium are studied. The new methods, based on the low-temperature plasma processes using dielectric barrier discharge, do not require the use of high temperature or the substrate that would contain one of the compounds of BaTiO$_3$ thin layer.

The first of the presented methods (method I) was based on transferring the titanium and barium ions from tetrahydrofurfuryl barium and titanium (IV) oxide ($C_{30}H_{54}BaO_{12}Ti$) – the organic precursor to the copper substrate. So far, the most commonly used organic precursors of those elements were Ba(CH$_3$COO)$_2$ (barium acetate) [1,11,17] and Ti(OiPr)$_4$ (titanium tetra-isopropoxide) [1,4,18]. In this paper we use only one metalorganic precursor, that significantly simplifies the experimental setup.
The European Physical Journal Applied Physics

Fig. 1. Scheme of the experimental setup; (1) a working gas vessel, (2) mass flow controllers, (3) a shuttle valve, (4) a bubbling washer, (5) a plasma reactor, (6) a power supply.

The second presented method (method II) consisted in transferring the compounds of titanium and barium from a ceramic plate made of barium titanate to the copper substrate.

In this paper we present the study of preparing thin layers containing barium and titanium in the most simplified experimental setup. This simplicity was obtained by using the dielectric barrier discharge generated under the atmospheric pressure at the ambient temperature, a multicomponent organic oxide – only one precursor of all compounds of the desired thin layer and ferroelectric ceramics as the other precursor.

2 Experimental section

A scheme of the experimental setup is shown in Figure 1. The experimental setup consisted of: a working gas vessel (argon or oxygen), a mass flow controllers, a bubbling washer with the organic precursor, a plasma reactor and the power supply. Argon (99.999%) flow rate amounted to 0.06–1.10 NL/min and that of oxygen (99.999%) 1.67–2.0 NL/min. Experiments were carried out in 20–60 min. The discharge was generated with frequency of 50 kHz and the voltage amounted to 0.57–1.75 kV.

Thin films were prepared by means of two methods – method I and method II. The first one (method I) consisted in preparing a thin layer containing titanium and barium with the use of precursor of Ti$^{4+}$ and Ba$^{2+}$ ions. The precursor was the organometallic compound – tetrahydrofurfuryl barium and titanium (IV) oxide (C$_{30}$H$_{54}$BaO$_{12}$Ti solution with tetrahydrofurfuryl alcohol and ethanol – Sigma-Aldrich). The method I was performed in two ways. The first way consisted of two stages. In the first stage, the working gas (argon) flowing through the bubbling washer with the precursor washed away the organometallic compound and delivered it to the discharge zone. There was a discharge generated between the metal (copper) surface of the high-voltage electrode and the surface of the dielectrics mounted to the grounded electrode. In the second stage, the obtained layer was etched in the discharge generated in the atmosphere of a mixture of argon and oxygen. The second way consisted of only one stage (performed for Cu6 sample). The working gas (argon) flowing through the bubbling washer washed away the molecules of the precursor. The stream of argon with the vapor of the precursor was mixed with oxygen after the bubbling washer, but before the plasma reactor. Mixed components of the reaction were delivered to the discharge zone, which was the same as in the previously mentioned process. A few additional materials were used as the dielectric barriers. They were: polyimide (PI), polycarbonate (PC) and poly(methyl methacrylate) (PMMA).

The second method (method II) consisted in generating the discharge in argon between the high-voltage copper electrode and the grounded electrode made of BaTiO$_3$.

Two different methods were used to analyze the obtained layers: the infrared spectroscopy with Fourier transformation (FTIR) and the secondary ion mass spectrometry (SIMS). The research carried out by FTIR was performed by means of Nicolet FTIR spectrometer (ThermoScientific IS10 company), equipped with the ATR (attenuated total reflectance – the method of total internal reflection) with a ZnSe crystal. Number of scans was 64, the spectra were measured with resolution of 4 cm$^{-1}$. The research carried out by SIMS was performed using secondary ion mass spectrometer – SAJW-05 [19]. The etching with Ar$^+$ ions was performed with the energy of 3 keV. The depth profile analyses were performed at 0–3 µ depth range and additionally at 0–100 nm depth range. The depth of the resulting craters was measured with the stylus profilometer Alpha-step 100 Tencor.

3 Results and Discussion

3.1 Theoretical assumptions for the methods

For the method I, it was assumed that the working gas (argon) flowing through the bubbling washer with
the precursor would wash away the vapor of the organometallic compound and would introduce it to the discharge zone. The large organic molecule would be decomposed in the argon plasma. Barium and titanium in the form of atoms, oxides or partially chemically bounded in the organic phase would be deposited on the surfaces of both electrodes. Whereas the part of the precursor that contains carbon, oxygen and hydrogen would be decomposed in the argon plasma to light organic compounds and would be removed with the working gas out of the discharge zone.

The preliminary FTIR analysis showed that during the plasma reaction, mainly the organic layer is deposited on the copper substrate. Therefore, the method I was supplemented with the additional stage – etching the obtained organic layer in the oxygen plasma. Ozone, oxygen radicals and excited molecules of oxygen formed in the discharge would remove or decrease the organic layer. Furthermore, during the reaction, oxygen molecules would form the chemical structure of barium titanite or titanium oxides on the surface of substrate. The mixture of argon and oxygen was applied to excite plasma easier.

For the method II, it was assumed that plasma affecting the surface of the ferroelectric plate would transfer the compounds containing barium and titanium from the ceramics to the surface of the copper substrate.

3.2 SIMS analysis

Figure 3a presents the results of SIMS depth profile analysis of the samples Cu1, Cu2, Cu3, Cu4 and Cu6. The \( ^{12}\text{C}^+ \), \( ^{48}\text{Ti}^+ \) and \( ^{138}\text{Ba}^+ \) secondary ion currents are normalized versus \( ^{63}\text{Cu}^+ \) secondary ion current. Plots of Cu1 and Cu2 samples show significant contribution of carbon presence in the sputtering range corresponding to 600 nm and 3 \( \mu\text{m} \) depth range respectively. Plots of Cu3 and Cu4 samples show higher contribution of titanium with respect to Cu1 and Cu2 samples.

Both Cu1 and Cu2 samples contain a layer of carbon. The carbon deposited on the surface of the copper substrate comes from the organic layer, which was formed during the plasma process carried out by means of the method I. For these two samples, only the first stage of the method I was performed. It seems that the organic layer on the surface of the Cu1 sample fully covers the copper substrate and is dense in comparison with that of the Cu2 sample, on which the organic layer is thicker, but also more porous, so the other analyzed elements may be seen through it. The Cu3 sample was also treated with the method I, but in this case, both stages of the process were completed – the reaction with the precursor and plasma etching in oxygen was performed.

The organic coating of the Cu3 sample is much thinner in comparison with those of the Cu1 and Cu2 samples, which indicates that the plasma reaction in oxygen resulted in partial etching of this layer. The Cu4 sample was treated in argon with the use of the method II, in the discharge with the ceramic barrier. The layers on the Cu3 and Cu4 samples contain a lot more of titanium in comparison with the layer on the Cu2 sample. The samples Cu1-Cu4 contain a small amount of barium.

The additional SIMS study was performed to analyze the profile in the range of 0–100 nm (Fig. 3b). In this analysis three secondary ion currents of \( ^{63}\text{Cu}^+ \), \( ^{48}\text{Ti}^+ \) and \( ^{138}\text{Ba}^+ \) were examined. Four samples were analyzed: Cu2, Cu3, Cu4 and Cu6.

The Cu6 sample shows the presence of a thin layer on the copper substrate. This layer is about 20 nm thick and is enriched in titanium and barium. The distribution of these two elements is different than in the samples Cu2, Cu3 and Cu4. The Cu3 and Cu4 samples show wide distribution of titanium and barium in the range to 120 nm, without enrichment in the range of 20 nm depth.

The results of SIMS show that the most promising process was this performed for the sample Cu6. The layer for this sample was obtained by the method I (Tab. 1). The reaction conditions for this sample were obtained by the method I (Tab. 1). The reaction conditions for this sample were different than those for the other samples. A higher argon flow rate was applied, therefore larger amount of the precursor was transferred to the discharge zone. In addition, oxygen was
Table 1. The experimental parameters.

<table>
<thead>
<tr>
<th>Sample</th>
<th>Method/stage</th>
<th>VAr [NL/min]</th>
<th>VO₂ [NL/min]</th>
<th>Dielectric</th>
</tr>
</thead>
<tbody>
<tr>
<td>Cu1</td>
<td>I/1</td>
<td>0.06</td>
<td>–</td>
<td>PC</td>
</tr>
<tr>
<td>Cu2</td>
<td>I/1</td>
<td>0.28</td>
<td>–</td>
<td>PMMA</td>
</tr>
<tr>
<td>Cu3</td>
<td>I/1+2</td>
<td>0.14</td>
<td>1.67</td>
<td>PI</td>
</tr>
<tr>
<td>Cu4</td>
<td>II</td>
<td>0.20</td>
<td>–</td>
<td>BaTiO₃</td>
</tr>
<tr>
<td>Cu5</td>
<td>I/1</td>
<td>0.12</td>
<td>–</td>
<td>PI</td>
</tr>
<tr>
<td>Cu6</td>
<td>I*</td>
<td>1.10</td>
<td>2.00</td>
<td>PMMA</td>
</tr>
</tbody>
</table>

*only one stage – reaction in flow of mixed Ar and O₂.

added to the reaction mixture in one stage with argon. This enabled the reaction between oxygen and the precursor in the gaseous phase, before depositing the organo-metallic molecules on the copper surface. However, in the reaction with two stages, as was in the case of the preparation of layer on the Cu3 sample, oxygen in the second stage reacted with the precursor already deposited on the surface of the substrate. The reaction runs easier in the gaseous phase, and additionally the total gas flow was significantly higher for the Cu6 than in the case of the preparation of the layers on the other samples.

Therefore in the reaction of the Cu6 sample it was more likely to: (1) reduce the amount of the organic layer deposited on the substrate and (2) increase the quantity of barium and titanium deposited on the surface.

The presented results improve the positive effect of the surface modification in the plasma and confirm the effectiveness of the method in the process of depositing a thin layer containing titanium and barium on the chosen substrate. Basing on these results, it can be concluded, that both, method I and method II, gave a positive result in the deposition of the thin layer containing certain amounts of Ti and Ba on the copper substrate. However, the method I, which was performed in only one stage (mixed stream of oxygen and argon), was more effective.

3.3 FTIR analysis

FTIR was used to determine the composition of the organic layer obtained on the copper substrate during the experiment carried out with the use of method I. The Cu5 sample – the sample after processing with the use of the first stage of the method I and the Cu3 sample – the samples after processing with the use of both stages of method I and the Cu6 sample – the sample after processing in mixed stream of argon and oxygen in the method I were examined. The organic layer formed on the copper substrate should contain functional groups that are present in the precursor solution and possibly groups of derivatives, which could be formed from the decomposition of the specific compounds. Figures 4 and 5 present the IR spectra of ethyl alcohol and tetrahydrofurfuryl alcohol – the solutions in the precursors mixture, whose IR spectra are shown in Figure 6. For a comparison, Figure 7 presents the spectra of the organic layers that were obtained on a copper substrate by means of the method I (Tab. 1).

The spectrum of tetrahydrofurfuryl barium and titanium oxide (precursor) looks similarly to the spectrum of tetrahydrofurfuryl alcohol – solvent, since both compounds are structurally similar and have the same functional groups, excluding the OH group, which is not present in the precursor molecule. Comparing all the presented spectra, it is easy to see that they have some common features – the main group at the same wavenumbers. Each of these spectra contains a group of ~3500 cm⁻¹, which corresponds to the OH group present in alcohol. The other similar features are: 2800–2900 cm⁻¹ signals,
Fig. 7. The IR spectra of the layers obtained on the copper substrate: (a) the sample after processing with the use of the first stage of the method I – Cu5, (b) the sample after processing with the use of both stages of method I – Cu3 and (c) the samples after processing in mixed stream of argon and oxygen in the method I – Cu6.

that correspond to the aliphatic CH carbon atoms that are not bound with unsaturated bonds. Groups occurring at 1400–1500 cm\(^{-1}\) could not be identified on the basis of tables of specific bonds. However, these are probably the groups corresponding with the unsaturated C-C bonds. The other similar features are 1000–1100 cm\(^{-1}\) signals, that correspond to CO groups in primary alcohols (and ethers). It is supposed that this group is higher for tetrahydrofurfuryl alcohol (Fig. 4), because it contains the oxygen bound in the ether group COC in its molecule. Similar in shape is the spectrum of the Cu5 sample (Fig. 7a), that may indicate the presence of ether groups in the surface layer of the sample.

The new groups for wavenumbers \(~1600–1700\) cm\(^{-1}\), which are not present in the spectrum of any of the solvents, were in the spectrum of the layers obtained in plasma (Fig. 7) and in the spectrum of the precursors solution (Fig. 6).

To identify these groups we had to refer to the example of two compounds similar in structure: ethyl alcohol (C\(_2\)H\(_5\)OH) and the other in which hydrogen atom is replaced with sodium (C\(_2\)H\(_5\)ONa) [20]. It was noticed that the C\(_2\)H\(_5\)ONa spectrum included additional groups for wavenumbers \(~1600–1700\) cm\(^{-1}\). The signal at this point probably corresponds with CO combined with oxygen, which is bonded ionically with sodium cation. That caused a shift of this signal toward the higher wavenumbers. A similar situation occurs when we consider the structure of the precursor and tetrahydrofurfuryl alcohol. The precursor cations Ba\(^{2+}\) and Ti\(^{4+}\) are bonded to the oxygen atom. A similar oxygen atom in the molecule is related to the hydrogen atom in the solvent molecule. Thus, the spectrum of the precursor contains the additional spectrum with the wavenumber \(~1600–1700\) cm\(^{-1}\). This group is also observed in the spectrum of the layers obtained on the copper substrates (Fig. 7), indicating that the precursor had evaporated from the bubbling washer during the process and was deposited on the copper substrate. The presence of oxidized groups corresponding with the cations Ba\(^{2+}\) and Ti\(^{4+}\) indicates the presence of these cations in the examined layer.

Comparing the spectrum of the Cu5 (Fig. 7a), Cu3 (Fig. 7b) and Cu6 (Fig. 7c) samples, we can see that they are similar. But there are differences both in the signal level and in the shape of the signals corresponding to the groups combined with oxygen. It is supposed that the signal corresponding to the groups CH (2800–2900 cm\(^{-1}\)) decreased in comparison with the CO signal (1000–1100 cm\(^{-1}\)) for samples Cu3 and Cu6 in comparison with Cu5 sample.

This indicates that the oxygen plasma partially removed the organic layer from the substrate and left a layer containing inorganics in the form of barium and titanium. The growth of CO signals combined with oxygen ion shows an enrichment of the obtained layer in oxygen. Based on the results, it can be concluded that the obtained layers contain barium and titanium.

4 Conclusion

On the basis of the test results it can be stated that it is possible to obtain a layer containing titanium and barium on the copper substrate with the use of dielectric barrier discharge at atmospheric pressure. The results of analysis by the secondary ion mass spectrometry (SIMS) showed directly that both method I and method II gave positive results in the deposition of a certain amount of compounds containing barium and titanium. However, method I turned out to be more effective in obtaining
this kind of thin layer. By contrast, the results of the analysis by FTIR allow us to indirectly draw conclusions about the contents of the required elements in the examined layers obtained by the method I. The FTIR study showed that the layer deposited on a copper substrate contained the group-CO combined with the oxygen connected with metal ion binding. The only metals in the solution are barium and titanium, so it can be concluded that the obtained layer had to contain these elements. FTIR study also showed that the oxygen etching in the method I resulted in decrease of the organic layer. Barium and titanium can be found on the plasma modified surface but they are dispersed in the organic phase.

This work was supported by the Tele & Radio Research Institute Statutory Fund.

References


Open Access This article is distributed under the terms of the Creative Commons Attribution Noncommercial License which permits any noncommercial use, distribution, and reproduction in any medium, provided the original author(s) and source are credited.